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Standards



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Semiconductor Equipment and Materials International

SEMI International Standards Program

PV - Automation Committee Europe

PV Wafer Traceability Task Force

5th Meeting

March 22nd 2011, 14:30 - 18:00 (MET)

Europe PV Fab Managers Forum
Hotel Concorde Berlin Augsburger Strasse 41 D-10789 Berlin Germany
Meeting Room : Vendome A

SEMI Staff contact: Carlos Lee, Mobile: +32 473 300433

Agenda

Objective of the Meeting: Preparation of ballot for standard proposal "Specification for Marking of PV Wafer"

Co-chairs: István Győry / Innovation Engineering & Services GmbH. (IE&S)
Andreas Behr / InnoLas GmbH

Coaching: Gerhard Kleineidam / InReCon AG
SEMI Europe Regional Standards Committee Advisor

14:30	Welcome and Introductions	István Győry, all
14:45	SEMI Reminders and Basic Rules	Gerhard Kleineidam
15:00	Agenda and TF goals	István Győry
15:10	Decisions and open points	István Győry
15:20	SNARF "Edge Marking" (brick marking)	Jürgen Grosser
15:30	SNARF "MES Interface"	István Győry
15:40	Q-Cells Lasermarking IP - scope & terms	Ralf Paugstadt
15:50	Result the Reading Test Fraunhofer ISE	Stefan Rein
16:00	Result the Reading Test COGNEX	Walter Braitsch
16:10	Result the Reading Test SICK	Steffen Nübling
16:20	Result the Reading Test MANZ	Matthias Roosz
16:30	Result the Reading Test IOSS	Joachim Gäßler
16:40	Coffee break	all
17:05	Discussion	all
17:25	Decisions and open points	all
17:40	Next Steps	István Győry
17:50	Adjourn	all